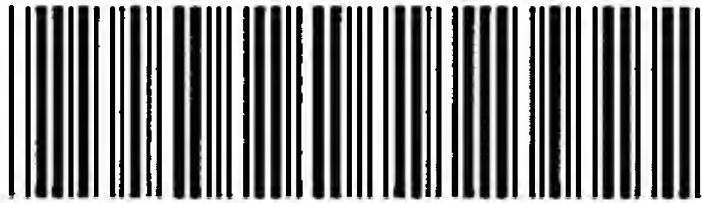


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,717	LAM ET AL.	
	Examiner	Art Unit	
	Michael A. Friedhofer	2832	

SEARCHED			
Class	Subclass	Date	Examiner
200	5a,406, 512,517, 302.1, 302.2	2/3/2005	MAF
200	310,313	2/3/2005	MAF
200	314,341	2/3/2005	MAF
200	345	2/3/2005	MAF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
200	5a,406	2/3/2005	MAF
200	512,517	2/3/2005	MAF
200	302.1,314	2/3/2005	MAF
200/302.2,310,313,341, 345		2/3/2005	MAF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR